
**Non-destructive testing — Radiation
methods for computed tomography —**

**Part 3:
Operation and interpretation**

*Essais non destructifs — Méthodes par rayonnements pour la
tomographie informatisée —*

Partie 3: Fonctionnement et interprétation





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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT) see the following URL: www.iso.org/iso/foreword.html

This document was prepared by the European Committee for Standardization (CEN) (as EN 16016-3) and was adopted, under a special "fast-track procedure", by Technical Committee ISO/TC 135, *Non-destructive testing*, Subcommittee SC 5, *Radiographic testing*, in parallel with its approval by the ISO member bodies.

This first edition of ISO 15708-3 cancels and replaces ISO 15708-2:2002, of which it forms the subject of a technical revision. It takes into consideration developments in computed tomography (CT) and computational power over the preceding decade.

A list of all parts in the ISO 15708 series can be found on the ISO website.

Non-destructive testing — Radiation methods for computed tomography —

Part 3: Operation and interpretation

1 Scope

This document presents an outline of the operation of a computed tomography (CT) system and the interpretation of results with the aim of providing the operator with technical information to enable the selection of suitable parameters.

It is applicable to *industrial* imaging (i.e. non-medical applications) and gives a consistent set of CT performance parameter definitions, including how those performance parameters relate to CT system specifications.

This document deals with computed axial tomography and excludes other types of tomography such as translational tomography and tomosynthesis.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 15708-1:2017, *Non-destructive testing — Radiation methods for computed tomography — Part 1: Terminology*

ISO 15708-2:2017, *Non-destructive testing — Radiation methods for computed tomography — Part 2: Principle, equipment and samples*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 15708-1 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

4 Operational procedure

4.1 General

For target-oriented computer tomography (CT) inspection procedures, the test and measurement tasks are defined in advance with regard to the size and type of features/defects to be verified; for example, through the specification of appropriate acceptance levels and geometry deviations. In the following, the process steps of a CT application are described and information on its implementation provided.